

Analog Devices Welcomes Hittite Microwave Corporation

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GaAs pHEMT MMIC 1/2 WATT POWER AMPLIFIER, 16 - 24 GHz

Typical Applications

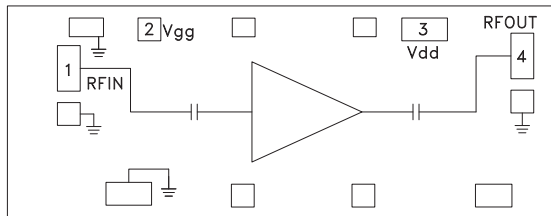
The HMC757 is ideal for:

- Point-to-Point Radios
- Point-to-Multi-Point Radios
- VSAT
- Military & Space

Features

- Saturated Output Power: +30 dBm @ 30% PAE
- High Output IP3: +37 dBm
- High Gain: 22 dB
- DC Supply: +7V @ 395mA
- 50 Ohm Matched Input/Output
- Die Size: 2.4 x 0.9 x 0.1 mm

Functional Diagram



General Description

The HMC757 is a three stage GaAs pHEMT MMIC 1/2 Watt Power Amplifier which operates between 16 and 24 GHz. The HMC757 provides 22 dB of gain, and +30 dBm of saturated output power at 30% PAE from a +7V supply. The RF I/Os are DC blocked and matched to 50 Ohms for ease of integration into Multi-Chip-Modules (MCMs). All data is taken with the chip in a 50 Ohm test fixture connected via 0.025 mm (1 mil) diameter wire bonds of length 0.31 mm (12 mils).

Electrical Specifications, $T_A = +25^\circ\text{C}$, $V_{dd} = +7\text{V}$, $I_{dd} = 395\text{mA}$ ^[1]

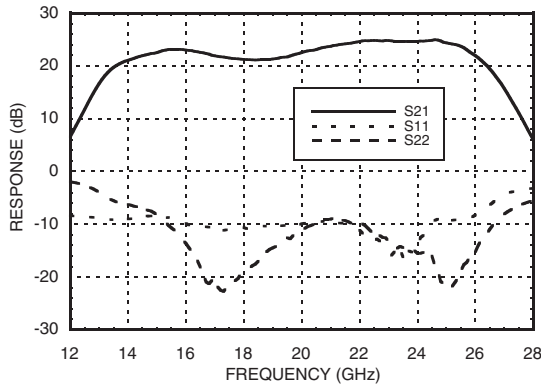
Parameter	Min.	Typ.	Max.	Min.	Typ.	Max.	Units
Frequency Range	16 - 20		20 - 24				GHz
Gain	19	22		21	24		dB
Gain Variation Over Temperature		0.028			0.032		dB/°C
Input Return Loss		10			12		dB
Output Return Loss		15			13		dB
Output Power for 1 dB Compression (P1dB)	27	29		27	29.5		dBm
Saturated Output Power (P _{sat})		30			30		dBm
Output Third Order Intercept (IP ₃) ^[2]		38			36		dBm
Total Supply Current (I _{dd})		395			395		mA

[1] Adjust V_{gg} between -2 to 0V to achieve I_{dd}= 395mA typical.

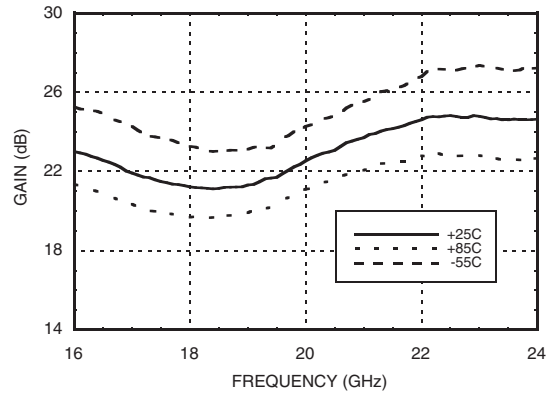
[2] Measurement taken at +7V @ 395mA, P_{out} / Tone = +17 dBm

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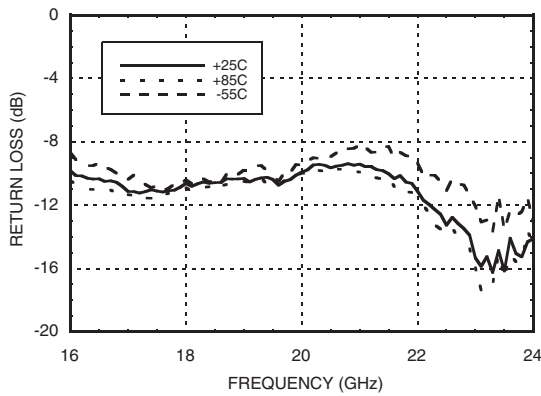
**Broadband Gain &
Return Loss vs. Frequency**



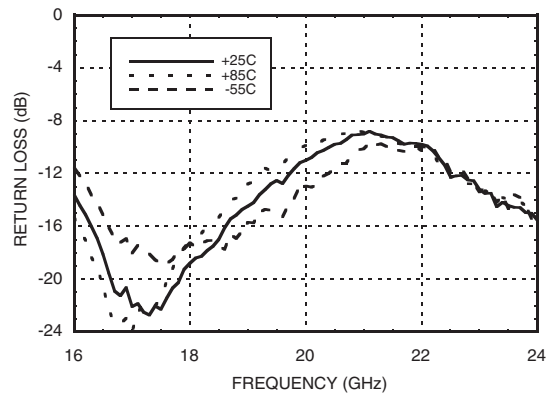
Gain vs. Temperature



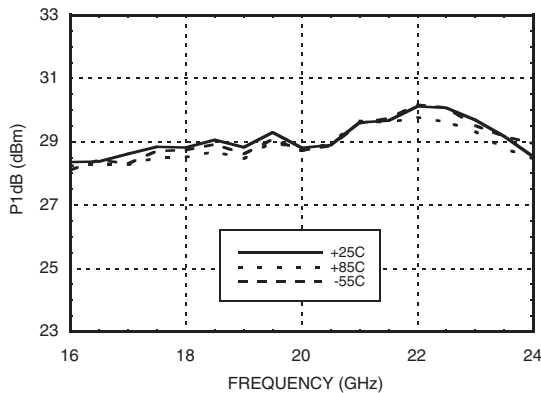
Input Return Loss vs. Temperature



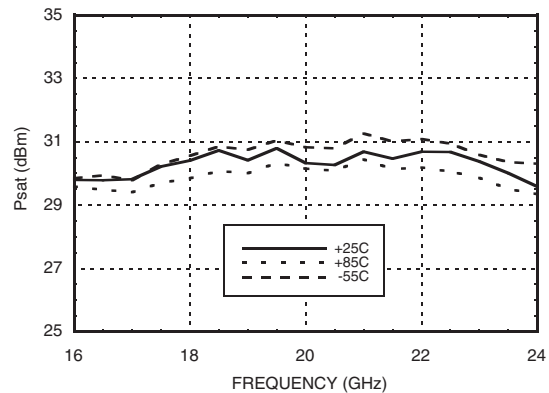
Output Return Loss vs. Temperature



P1dB vs. Temperature

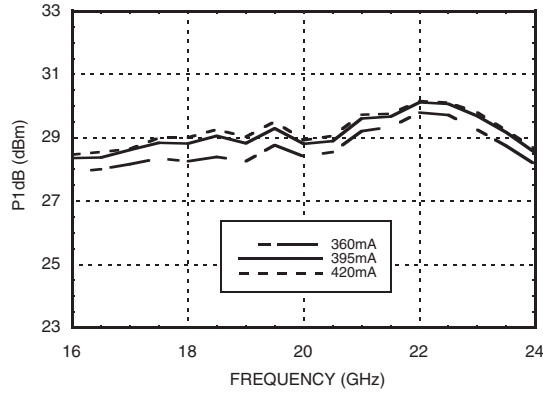


Psat vs. Temperature

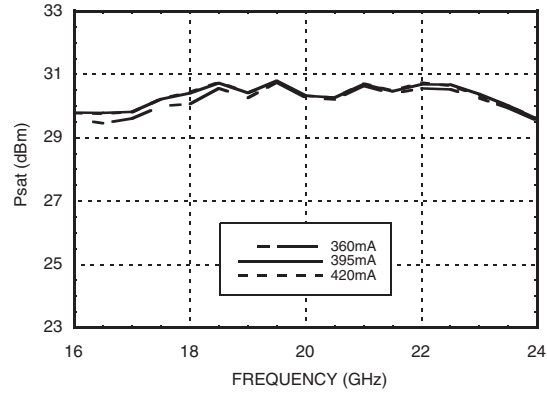


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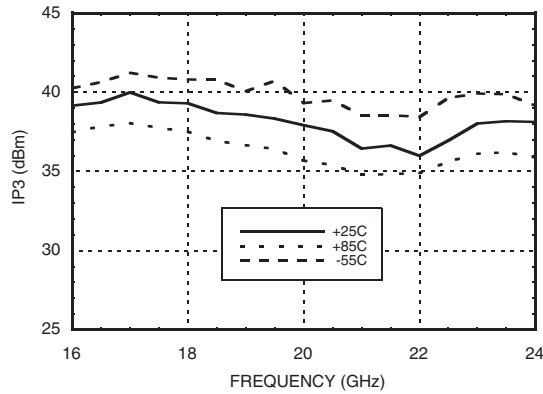
P1dB vs. Current



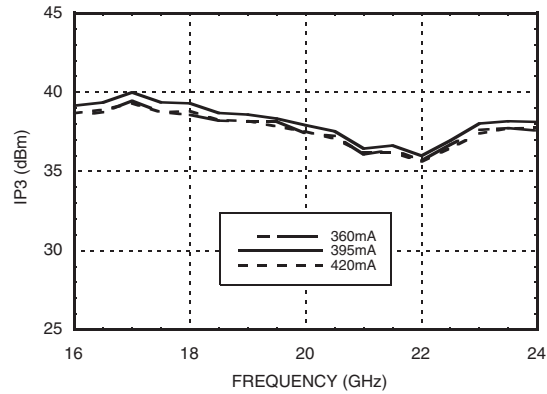
Psat vs. Current



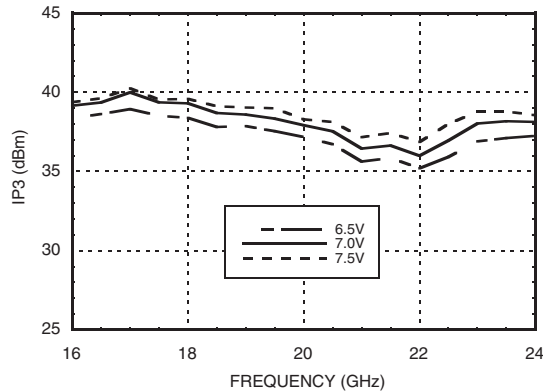
Output IP3 vs. Temperature, Pout/Tone = +17 dBm



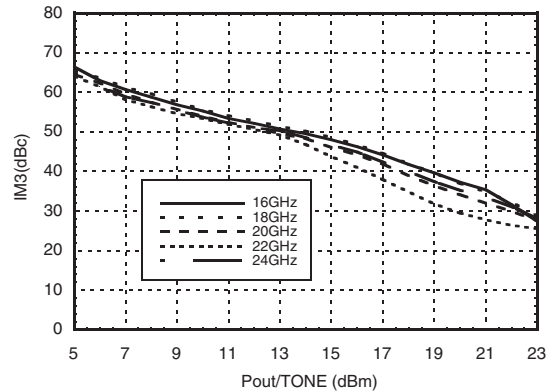
Output IP3 vs. Supply Current, Pout/Tone = +17 dBm



Output IP3 vs. Supply Voltage, Pout/Tone = +17 dBm

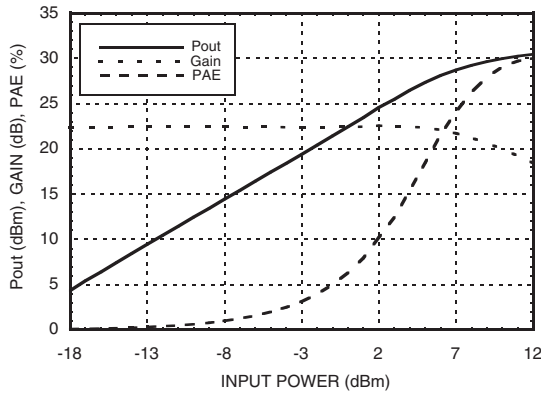


Output IM3

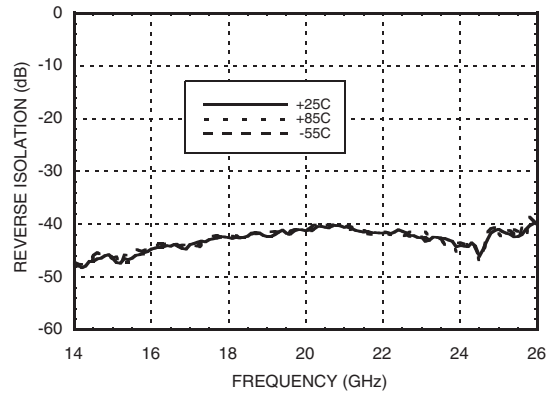


GaAs pHEMT MMIC 1/2 WATT POWER AMPLIFIER, 16 - 24 GHz

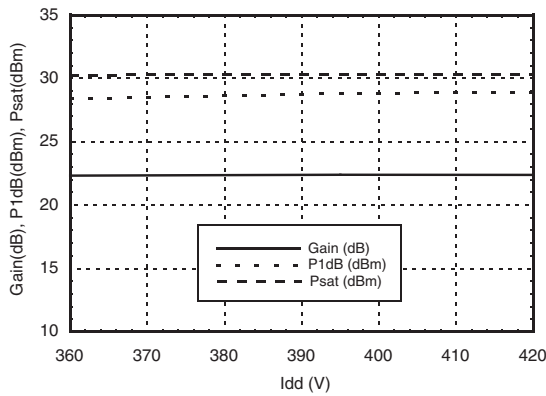
Power Compression @ 20 GHz



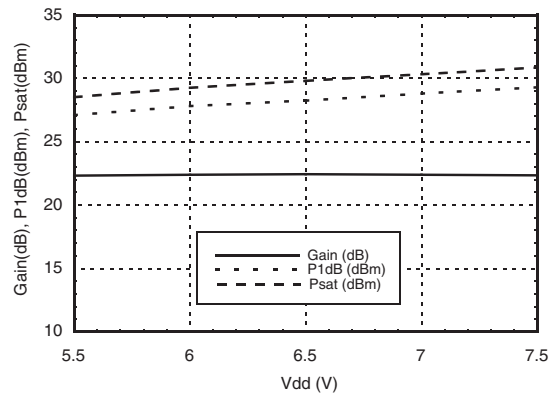
Reverse Isolation vs. Temperature



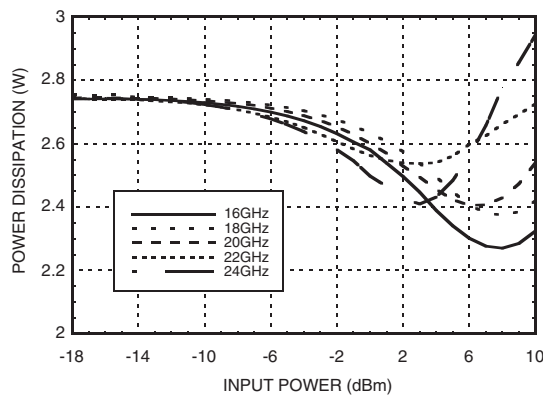
Gain & Power vs. Supply Current @ 20 GHz



Gain & Power vs. Supply Voltage @ 20 GHz



Power Dissipation



**GaAs pHEMT MMIC 1/2 WATT
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Absolute Maximum Ratings

Drain Bias Voltage (Vdd)	8V
RF Input Power (RFIN)	+26 dBm
Junction Temperature	150 °C
Continuous Pdiss (T= 85 °C) (derate 43 mW/°C above 85 °C)	2.8 W
Thermal Resistance (junction to die bottom)	23.4 °C/W
Storage Temperature	-65 to +150 °C
Operating Temperature	-55 to +85 °C

Typical Supply Current vs. Vdd

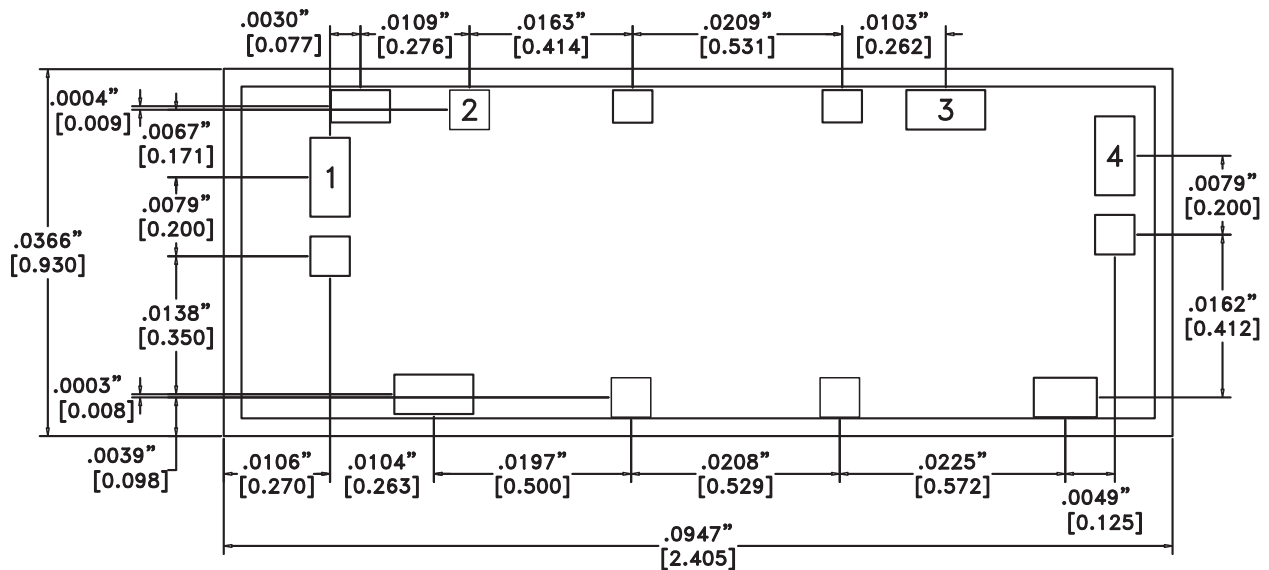
Vdd (V)	Idd (mA)
+6.5	375
+7.0	395
+7.5	411

Note: Amplifier will operate over full voltage ranges shown above Vgg adjusted to achieve Idd = 395mA at +7V



**ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS**

Outline Drawing



Die Packaging Information [1]

Standard	Alternate
GP-2 (Gel Pack)	[2]

[1] Refer to the "Packaging Information" section for die packaging dimensions.

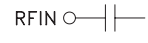
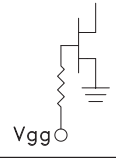
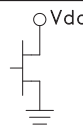
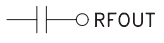
[2] For alternate packaging information contact Hittite Microwave Corporation.

NOTES:

- ALL DIMENSIONS ARE IN INCHES [MM]
- DIE THICKNESS IS .004"
- TYPICAL BOND PAD IS .004" SQUARE
- BACKSIDE METALLIZATION: GOLD
- BOND PAD METALLIZATION: GOLD
- BACKSIDE METAL IS GROUND.
- CONNECTION NOT REQUIRED FOR UNLABELED BOND PADS.
- OVERALL DIE SIZE ± .002

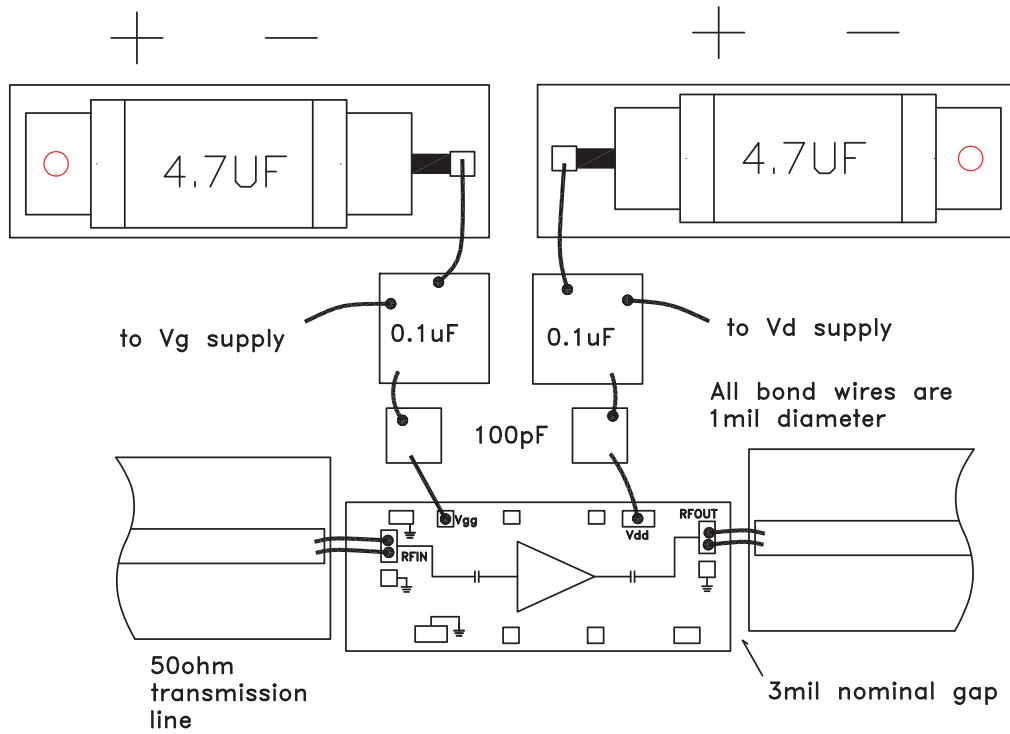
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Pad Descriptions

Pad Number	Function	Description	Interface Schematic
1	RFIN	This pad is AC coupled and matched to 50 Ohms.	
2	Vgg	Gate control for PA. Adjust Vgg to achieve recommended bias current. External bypass caps 100pF, 0.1uF and 4.7uF are required.	
3	Vdd	Drain bias for amplifier. External bypass caps 100pF, 0.1uF and 4.7uF are required	
4	RFOUT	This pad is AC coupled and matched to 50 Ohms.	

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Assembly Diagram



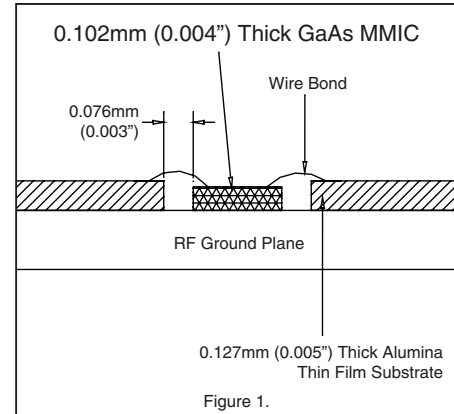
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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be located as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm to 0.152 mm (3 to 6 mils).



Handling Precautions

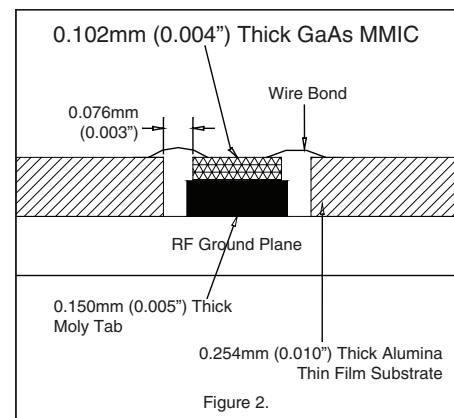
Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against > ± 250V ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.



General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip may have fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025mm (1 mil) diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31mm (12 mils).